

Initial Product/Process Change Notification

Document # : IPCN22313Z Issue Date: 2 August 2018

Title of Change:	Transfer of wafer fabrication operations for ON Semiconductor Zener products to ON Niigata, Japan, and		
	change top metal to AlSiCu.		
Proposed Changed Material First Ship Date:	2 September 2019		
Current Material Last Order Date:	7 July 2019 Orders received after the Current Material Last Order Date expiration are to be considered as orde new changed material as described in this PCN. Orders for current (unchanged) material after this dat be per mutual agreement and current material inventory availability.		
Current Material Last Delivery Date:	7 July 2019 The Current Material Last Delivery Date may be subject to change based on build and depletion of current (unchanged) material inventory.		
Product Category:	Active components – Discrete components		
Contact information:	Contact your local ON Semiconductor Sales Office or < <u>Hiroshi.Koizumi@onsemi.com</u> >		
Samples:	Contact your local ON Semiconductor Sales Office to place sample order or < <u>PCN.samples@onsemi.com</u> > Sample requests are to be submitted no later than 45 days after publication of this change notification.		
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or < Nicky.Siu@onsemi.com>.		
Type of Notification:	This is an Initial Product/Process Change Notification (IPCN) sent to customers. IPCNs are issued at least 30 days prior to the issuance of the Final Change Notice (FPCN). An IPCN is an advance notification about an upcoming change and contains general information regarding the change details and devices affected. It also contains the preliminary reliability qualification plan. The completed qualification and characterization data will be included in the Final Product/Process Change Notification (FPCN). This IPCN notification will be followed by a Final Product/Process Change Notification (FPCN) at least 12 months prior to implementation of the change. In case of questions, contact < <u>PCN.Support@onsemi.com</u> >.		
Change Category	Type of Change		
Process – Wafer Production	New / change of metallization (specifically chip frontside)" Move of all or part of wafer fab to a different location/site/subcontractor (qualification of an additional manufacturing site)		

Description and Purpose:

This is the Initial Notification by ON Semiconductor notifying customers of its plan to transfer fab site from ISMF (Malaysia) to Niigata (Japan) as qualified wafer source for NZener, and change top metal to 2um AlSiCu.

Niigata Fab facility is an ON Semiconductor owned wafer fab that has been producing products for ON Semiconductor. Several existing technologies within ON Semiconductor's product families are currently sourced from Niigata Fab. ON Semiconductor Niigata Wafer Fab is an internal factory that is ISO/TS16949 and ISO-9001 certified.

Material to be changed	Before Change Description	After Change Description	
Wafer fab	ON Semiconductor ISMF FAB, Malaysia	ON Semiconductor Niigata, Japan	
Top metal	AlSi 2um	AlSiCu 2um	

There is no product marking change as a result of this change



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Reason / Motivation for Change: Anticipated impact on fit, form, function, reliability, product safety or	 Change benefits for customer: unconstraint capacity Risk for late release for customer No ISMF supply after Proposed Changed Material First Ship Date Limited ability to support bridge build availability. The device has been qualified and validated based on the same Product Specification. The device has successfully passed the qualification tests. Potential impacts can be identified, but due to testing performed by ON Semiconductor in relation to the PCN, associated risks are verified and excluded. 					
manufacturability:	No anticipated impacts.					
Sites Affected:	ON Semiconductor Sites: ON ISMF, Malaysia ON Leshan, China ON Niigata, Japan		iites:			
Marking of Parts/ Traceability of Change:	Affected devices from ON Semiconductor with date code First Ship Date and greater is sourced from ON Semiconductor Niigata, Japan.					
Reliability Data Summary: QV DEVICE NAME: SZMM3Z75VT1G PACKAGE: SOD323						
Test		Cc	ndition	Interval	l	
	D323		ondition o rated Tj=150°C	Interval 2016hrs		
Test SSOP	D323 Specification AEC-Q101-REV-D1	IZ max, Ta t				
Test SSOP (SSOL)	D323 Specification AEC-Q101-REV-D1 (JESD22-A108)	IZ max, Ta t Ta Ta=+25°C,	o rated Tj=150°C	2016hrs		
Test SSOP (SSOL) HTSL	D323 Specification AEC-Q101-REV-D1 (JESD22-A108) JESD22-A103 MIL-STD-750 (M1037)	IZ max, Ta t Ta Ta=+25°C, On/o	o rated Tj=150°C = 150°C delta Tj=100°C	2016hrs 2016hrs		
Test SSOP (SSOL) HTSL IOL	D323 Specification AEC-Q101-REV-D1 (JESD22-A108) JESD22-A103 MIL-STD-750 (M1037) AEC-Q101	IZ max, Ta t Ta Ta=+25°C, On/c Temp = - Temp = 130°C, 85% F	o rated Tj=150°C = 150°C delta Tj=100°C off = 2 min	2016hrs 2016hrs 30000 cyc		
Test SSOP (SSOL) HTSL IOL TC	D323 Specification AEC-Q101-REV-D1 (JESD22-A108) JESD22-A103 MIL-STD-750 (M1037) AEC-Q101 JESD22-A104	IZ max, Ta t Ta Ta=+25°C, On/c Temp = - Temp = 130°C, 85% P of	o rated Tj=150°C = 150°C delta Tj=100°C off = 2 min 55°C to +150°C H, ~ 18.8 psig, bias = 80%	2016hrs 2016hrs 30000 cyc 1000 cycles		
TestSSOP(SSOL)HTSLIOLTCHAST	D323 Specification AEC-Q101-REV-D1 (JESD22-A108) JESD22-A103 MIL-STD-750 (M1037) AEC-Q101 JESD22-A104 JESD22-A110	IZ max, Ta t Ta Ta=+25°C, On/c Temp = - Temp = 130°C, 85% R of 130°C, 85% RH	o rated Tj=150°C = 150°C delta Tj=100°C off = 2 min 55°C to +150°C H, ~ 18.8 psig, bias = 80% rated V	2016hrs 2016hrs 30000 cyc 1000 cycles 192hrs		

Electrical Characteristic Summary:

Electrical characteristics will be performed and updated per FPCN.



List of Affected Parts:				
Current Part Number	Qualification Vehicle			
SZMM3Z75VT1G				
SZMM3Z68VT1G				
SZMM3Z62VT1G				
SZMM3Z56VT1G				
SZMM3Z51VT1G				
SZMM3Z47VT1G				
SZMM3Z36VT1G				
SZMM3Z36VST1G				
SZMM3Z33VT1G				
SZMM3Z27VT1G				
SZMM3Z27VST1G				
SZMM3Z24VT1G				
SZMM3Z22VT1G				
SZMM3Z22VST1G	SZMM3Z75VT1G			
SZMM3Z20VT1G				
SZMM3Z18VT1G				
SZMM3Z18VST1G				
SZMM3Z16VT3G				
SZMM3Z16VT1G				
SZMM3Z16VST1G				
SZMM3Z15VT1G				
SZMM3Z13VT1G				
SZMM3Z13VST1G				
SZMM3Z12VST1G				
SZMM3Z11VT1G				
SZMM3Z10VT1G				
SZMM3Z10VST1G				